







MAX3232 SLLS4100 - JANUARY 2000 - REVISED JUNE 2021

MAX3232 3-V to 5.5-V Multichannel RS-232 Line Driver and Receiver With ±15-kV ESD Protection

1 Features

- RS-232 Bus-terminal esd protection exceeds ±15 kV using human-body model (HBM)
- Meets or exceeds the requirements of TIA/ EIA-232-F and ITU V.28 standards
- Operates with 3-V to 5.5-V V_{CC} supply
- Operates up to 250 kbit/s
- Two drivers and two receivers
- Low supply current: 300 µA Typical
- External capacitors: 4 × 0.1 µF
- Accepts 5-V logic input with 3.3-V supply
- Alternative high-speed terminal-compatible devices (1 Mbit/s)
 - SN65C3232 (-40°C to 85°C)
 - SN75C3232 (0°C to 70°C)

2 Applications

- **Industrial PCs**
- Wired networking
- Data center and enterprise networking
- **Battery-powered systems**
- **PDAs**
- Notebooks
- Laptops
- Palmtop PCs
- Hand-held equipment

3 Description

The MAX3232 device consists of two line drivers. two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE				
	SOIC (D) (16)	9.90 mm × 3.91 mm				
	SSOP (DB) (16)	6.20 mm × 5.30 mm				
MAX3232	SOIC (DW) (16)	10.30 mm × 7.50 mm				
	TSSOP (PW) (16)	5.00 mm × 4.40 mm				

For all available packages, see the orderable addendum at the end of the data sheet.

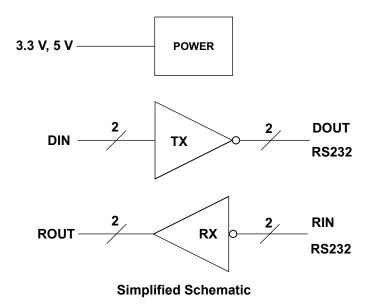




Table of Contents

1 Features	1	8.2 Functional Block Diagram	9
2 Applications		8.3 Feature Description	
3 Description		8.4 Device Functional Modes	
4 Revision History		9 Application and Implementation	
5 Pin Configuration and Functions		9.1 Application Information	
6 Specifications		9.2 Standard Application	
6.1 Absolute Maximum Ratings		10 Power Supply Recommendations	
6.2 ESD Ratings		11 Layout	
6.3 Recommended Operating Conditions		11.1 Layout Guidelines	
6.4 Thermal Information		11.2 Layout Example	
6.5 Electrical Characteristics — Device	<mark>5</mark>	12 Device and Documentation Support	14
6.6 Electrical Characteristics — Driver	<u>5</u>	12.1 Receiving Notification of Documentation L	Jpdates14
6.7 Electrical Characteristics — Receiver	6	12.2 Support Resources	
6.8 Switching Characteristics	6	12.3 Trademarks	
6.9 Typical Characteristics		12.4 Electrostatic Discharge Caution	
7 Parameter Measurement Information		12.5 Glossary	
8 Detailed Description		13 Mechanical, Packaging, and Orderable	
8.1 Overview		Information	14
4 Revision History NOTE: Page numbers for previous revisions ma	ay differ f	rom page numbers in the current version.	
Changes from Revision N (June 2017) to Re	vision O	(June 2021)	Page
		g, and Data center and enterprise computing	
		d PW packages in the <i>Thermal Information</i> table	
Changes from Revision M (April 2017) to Re	vision N	(June 2017)	Page
Changed the <i>Thermal Information</i> table			5
Changes from Revision L (March 2017) to Re	evision I		Page
Changed From: "±" To: "to" in the V _{CC} column			12
Changes from Revision K (January 2015) to	Revisio	n L (March 2017)	Page
Changed pin 16 (V _{CC}) in Typical Operating (Circuit an	d Capacitor Values	11
Changes from Revision J (January 2014) to	Revision	n K (January 2015)	
Added Applications, Device Information table	a Pin Fu		Page
table, Typical Characteristics, Feature Desc		inctions table. ESD Ratings table. Thermal Info	
	ription se	unctions table, ESD Ratings table, Thermal Info	rmation
	ription se ommenda	ction, Device Functional Modes, Application anations section, Layout section, Device and	rmation nd
Documentation Support section, and Mecha	ription se ommenda	ction, Device Functional Modes, Application ar	rmation nd
Changes from Revision I (January 2004) to I	ription se ommenda nnical, Pa Revision	ection, Device Functional Modes, Application and ations section, Layout section, Device and ackaging, and Orderable Information section	rmation and1

Submit Document Feedback

Deleted Ordering Information table......1



5 Pin Configuration and Functions

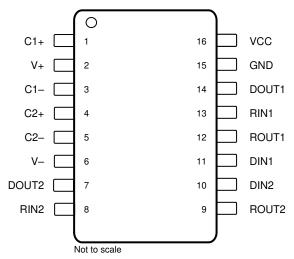


Figure 5-1. D, DB, DW, or PW Package, 16-Pin SOIC, SSOP, or TSSOP, Top View

Table 5-1. Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.	ITPE	DESCRIPTION
C1+	1	_	Positive lead of C1 capacitor
V+	2	0	Positive charge pump output for storage capacitor only
C1-	3	_	Negative lead of C1 capacitor
C2+	4	_	Positive lead of C2 capacitor
C2-	5	_	Negative lead of C2 capacitor
V-	6	0	Negative charge pump output for storage capacitor only
DOUT2	7	0	RS232 line data output (to remote RS232 system)
DOUT1	14	0	RS232 line data output (to remote RS232 system)
RIN2	8	I	RS232 line data input (from remote RS232 system)
RIN1	13	I	RS232 line data input (from remote RS232 system)
ROUT2	9	0	Logic data output (to UART)
ROUT1	12	0	Logic data output (to UART)
DIN2	10	I	Logic data input (from UART)
DIN1	11	I	Logic data input (from UART)
GND	15	_	Ground
V _{CC}	16	_	Supply Voltage, Connect to external 3 V to 5.5 V power supply



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range ⁽²⁾		-0.3	6	V
V+	Positive output supply voltage range ⁽²⁾		-0.3	7	V
V-	Negative output supply voltage range ⁽²⁾		-7	0.3	V
V+ – V–	Supply voltage difference ⁽²⁾			13	V
V	Input voltage range	Drivers	-0.3	6	V
V _I	input voitage range	Receivers	-25	25	V
V	Output voltage range	Drivers	-13.2	13.2	V
Vo	Output voltage range	Receivers	-0.3	V _{CC} + 0.3	V
TJ	Operating virtual junction temperature			150	°C
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) All voltages are with respect to network GND.

6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 RIN , DOUT, and GND pins ⁽¹⁾	15000	
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 All other pins ⁽¹⁾	3000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	1000	

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

(see Typical Operating Circuit and Capacitor Values)(1)

		·		MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage		V _{CC} = 3.3 V	3	3.3	3.6	V
V CC	Supply voltage		V _{CC} = 5 V	4.5	5	5.5	V
V	V Driver bink level in a structural to a c	DIN	V _{CC} = 3.3 V	2			V
V _{IH}	Driver high-level input voltage	Tilgh-lever input voltage	V _{CC} = 5 V	2.4			V
V _{IL}	Driver low-level input voltage	DIN				0.8	V
VI	Driver input voltage	DIN		0		5.5	V
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	Receiver input voltage	RIN		-25		25	V
т	Operating free air temperature		MAX3232C	0		70	°C
T _A	Operating free-air temperature		MAX3232I	-40		85	C

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.

Product Folder Links: MAX3232

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.4 Thermal Information

			MAX3232				
	THERMAL METRIC ⁽¹⁾	SOIC (D)	SSOP (DB)	SOIC (DW)	TSSOP (PW)	UNIT	
			16 PI	NS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	85.9	103.1	66.6	108.2	°C/W	
R _{0JC(top)}	Junction-to-case (top) thermal resistance	43.1	49.2	32.4	39.0	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	44.5	54.8	31.9	54.4	°C/W	
ΨЈТ	Junction-to-top characterization parameter	10.1	12	8.4	3.3	°C/W	
ΨЈВ	Junction-to-board characterization parameter	44.1	54.1	31.5	53.8	°C/W	
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	n/a	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Electrical Characteristics — Device

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽²⁾ (see Typical **Operating Circuit and Capacitor Values)**

	PARAMETER	TEST CONDITIONS		MIN	TYP ⁽¹⁾	MAX	UNIT
I _{CC}	Supply current	No load,	V _{CC} = 3.3 V to 5 V		0.3	1	mA

- All typical values are at V $_{CC}$ = 3.3 V or V $_{CC}$ = 5 V, and T $_{A}$ = 25°C. Test conditions are C1–C4 = 0.1 μ F at V $_{CC}$ = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V $_{CC}$ = 5 V \pm 0.5 V.

6.6 Electrical Characteristics — Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(3) (see Typical **Operating Circuit and Capacitor Values)**

	PARAMETER	TEST CONDITIO	NS N	/IN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	High-level output voltage	D_{OUT} at $R_L = 3 \text{ k}\Omega$ to GND, D_{IN}	= GND	5	5.4		V
V _{OL}	Low-level output voltage	D_{OUT} at $R_L = 3 \text{ k}\Omega$ to GND, D_{IN}	= V _{CC}	-5	-5.4		V
I _{IH}	High-level input current	V _I = V _{CC}			±0.01	±1	μA
I _{IL}	Low-level input current	V _I at GND			±0.01	±1	μA
I _{OS} (2)	Short-circuit output current	V _{CC} = 3.6 V V _O	= 0 V		±35	±60	mA
'os (=/	Short-circuit output current	V _{CC} = 5.5 V V _O	= 0 V		133	±00	ША
r _O	Output resistance	V_{CC} , V+, and V- = 0 V V_{O}	= ±2 V 3	300	10M		Ω

- All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.
- Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.
- Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5



6.7 Electrical Characteristics — Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(2) (see Typical **Operating Circuit and Capacitor Values)**

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	High-level output voltage	I _{OH} = -1 mA	V _{CC} - 0.6	V _{CC} - 0.1		V
V _{OL}	Low-level output voltage	I _{OL} = 1.6 mA			0.4	V
V Decitive gains input threehold valtage	V _{CC} = 3.3 V		1.5	2.4	V	
VIT+	V _{IT+} Positive-going input threshold voltage	V _{CC} = 5 V		1.8	2.4	V
.,	Negative-going input threshold voltage	V _{CC} = 3.3 V	0.6	1.2		V
V _{IT}	Negative-going input theshold voltage	V _{CC} = 5 V	0.8	1.5		V
V _{hys}	Input hysteresis (V _{IT+} – V _{IT-})			0.3		V
r _l	Input resistance	V _I = ±3 V to ±25 V	3	5	7	kΩ

6.8 Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(3) (see Typical **Operating Circuit and Capacitor Values)**

	PARAMETER	TEST C	ONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
	Maximum data rate	$R_L = 3 k\Omega$,	C _L = 1000 pF	150	250		kbit/s
	Maximum data rate	One D _{OUT} switching,	See Figure 7-1	150	250		KDII/S
	Driver Pulse skew ⁽²⁾	$R_1 = 3 k\Omega$ to $7 k\Omega$,	C _L = 150 to 2500 pF		300		no
t _{sk(p)}	Dilvei Fuise skew	KL - 3 K22 to 7 K22,	See Figure 7-2		300		ns
SR(tr)	Slew rate, transition region	$R_L = 3 k\Omega$ to $7 k\Omega$,	C _L = 150 to 1000 pF	6		30	V/µs
SK(ii)	(see Figure 7-1)	V _{CC} = 5 V	C _L = 150 to 2500 pF	4	-	30	v/µs
t _{PLH®)}	Propagation delay time, low- to high-level output	C = 150 pE			300		
t _{PHL®)}	Propagation delay time, high- to low-level output	- 150 pF	C _L = 150 pF		300		ns
t _{sk(p)}	Receiver Pulse skew ⁽³⁾				300		

All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.

Submit Document Feedback

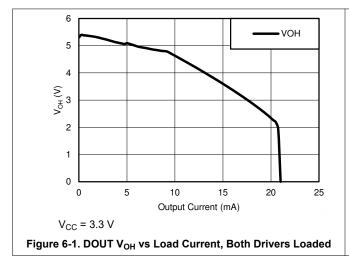
Copyright © 2021 Texas Instruments Incorporated

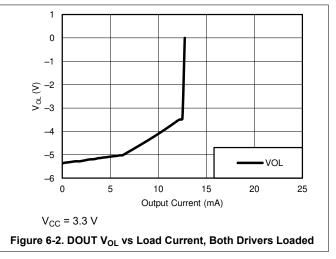
All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25 °C. Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.

⁽²⁾

Pulse skew is defined as $|t_{PLH} - t_{PHL}|$ of each channel of the same device. Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V. (3)

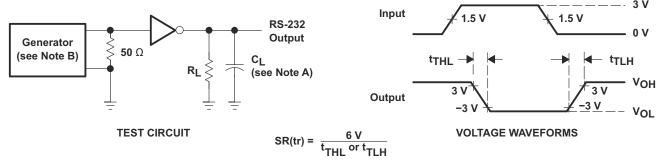
6.9 Typical Characteristics





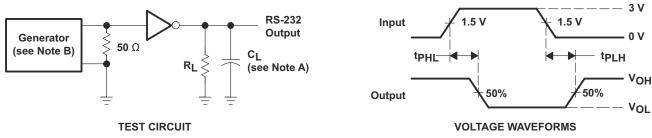


7 Parameter Measurement Information



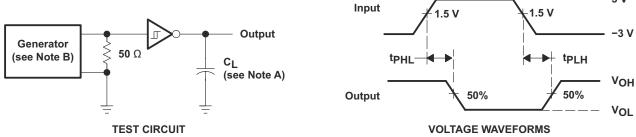
- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

Figure 7-1. Driver Slew Rate



- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_0 = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

Figure 7-2. Driver Pulse Skew



- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

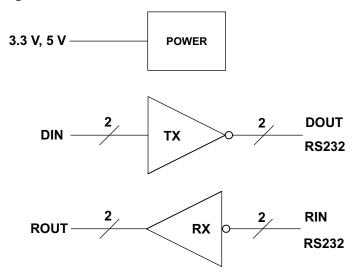
Figure 7-3. Receiver Propagation Delay Times

8 Detailed Description

8.1 Overview

The MAX3232 device consists of two line drivers, two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The device operates at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate. Outputs are protected against shorts to ground.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V- pins using a charge pump that requires four external capacitors.

8.3.2 RS232 Driver

Two drivers interface standard logic level to RS232 levels. Both DIN inputs must be valid high or low.

8.3.3 RS232 Receiver

Two receivers interface RS232 levels to standard logic levels. An open input will result in a high output on ROUT. Each RIN input includes an internal standard RS232 load.



8.4 Device Functional Modes

Table 8-1. Each Driver⁽¹⁾

INPUT DIN	OUTPUT DOUT
L	Н
Н	L

(1) H = high level, L = low level

Table 8-2. Each Receiver⁽¹⁾

INPUT RIN	OUTPUT ROUT
L	Н
Н	L
Open	н

(1) H = high level, L = low level, Open = input disconnected or connected driver off

8.4.1 V_{CC} powered by 3 V to 5.5 V

The device will be in normal operation.

8.4.2 V_{CC} unpowered, $V_{CC} = 0 V$

When MAX3232 is unpowered, it can be safely connected to an active remote RS232 device.

Submit Document Feedback

Copyright © 2021 Texas Instruments Incorporated

9 Application and Implementation

Note

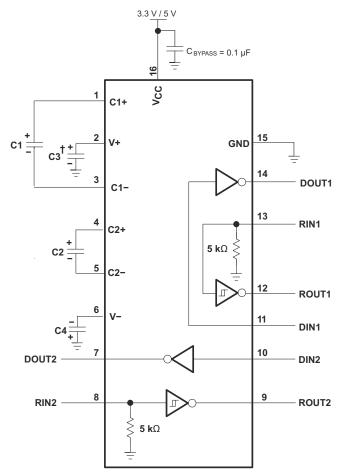
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

For proper operation, add capacitors as shown in Typical Operating Circuit and Capacitor Values.

9.2 Standard Application

ROUT and DIN connect to UART or general purpose logic lines. RIN and DOUT lines connect to a RS232 connector or cable.



- \dagger C3 can be connected to V_{CC} or GND.
- A. Resistor values shown are nominal.
- B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

Figure 9-1. Typical Operating Circuit and Capacitor Values



9.2.1 Design Requirements

- Recommended V_{CC} is 3.3 V or 5 V. 3 V to 5.5 V is also possible
- · Maximum recommended bit rate is 250 kbit/s.

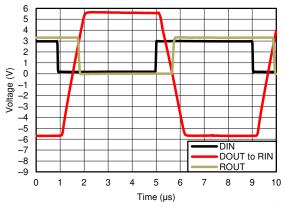
Table 9-1. V_{CC} vs Capacitor Values

V _{CC}	C1	C2, C3, C4
3.3 V ± 0.3 V	0.1 μF	0.1 μF
5 V ± 0.5 V	0.047 μF	0.33 μF
3 V to 5.5 V	0.1 μF	0.47 μF

9.2.2 Detailed Design Procedure

- All DIN, FORCEOFF and FORCEON inputs must be connected to valid low or high logic levels.
- · Select capacitor values based on VCC level for best performance.

9.2.3 Application Curves



 $V_{CC} = 3.3 \text{ V}$

Figure 9-2. 250 kbit/s Driver to Receiver Loopback Timing Waveform

10 Power Supply Recommendations

 V_{CC} should be between 3 V and 5.5 V. Charge pump capacitors should be chosen using table in Typical Operating Circuit and Capacitor Values.

Submit Document Feedback

Copyright © 2021 Texas Instruments Incorporated

11 Layout

11.1 Layout Guidelines

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times.

11.2 Layout Example

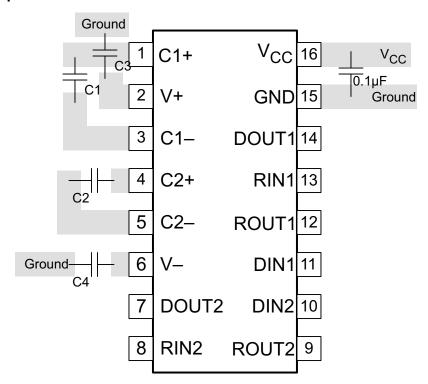


Figure 11-1. Layout Diagram



12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.3 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.

Product Folder Links: MAX3232

www.ti.com

31-Oct-2025

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
MAX3232CD	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	0 to 70	MAX3232C
MAX3232CDB	Obsolete	Production	SSOP (DB) 16	-	-	Call TI	Call TI	0 to 70	MA3232C
MAX3232CDBR	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CDBR.A	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CDR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3232C
MAX3232CDR.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3232C
MAX3232CDR1G4	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3232C
MAX3232CDR1G4.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3232C
MAX3232CDW	Obsolete	Production	SOIC (DW) 16	-	-	Call TI	Call TI	0 to 70	MAX3232C
MAX3232CDWR	Obsolete	Production	SOIC (DW) 16	-	-	Call TI	Call TI	0 to 70	MAX3232C
MAX3232CPW	Obsolete	Production	TSSOP (PW) 16	-	-	Call TI	Call TI	0 to 70	MA3232C
MAX3232CPWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CPWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CPWRE4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CPWRG4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CPWRG4.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232IDBR	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IDBR.A	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IDBRE4	Active	Production	SSOP (DB) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IDRG4	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-40 to 85	MAX3232I
MAX3232IDW	Obsolete	Production	SOIC (DW) 16	-	-	Call TI	Call TI	-40 to 85	MAX3232I
MAX3232IDWR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	MAX3232I
MAX3232IDWR.B	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3232I
MAX3232IPWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IPWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IPWRE4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IPWRG4	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IPWRG4.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I

PACKAGE OPTION ADDENDUM

www.ti.com 31-Oct-2025

- (1) Status: For more details on status, see our product life cycle.
- (2) Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.
- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF MAX3232:

■ Enhanced Product : MAX3232-EP

NOTE: Qualified Version Definitions:

Enhanced Product - Supports Defense, Aerospace and Medical Applications



www.ti.com 14-Nov-2025

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3232CDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3232CDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
MAX3232CDR1G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
MAX3232CPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232CPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.3	1.6	8.0	12.0	Q1
MAX3232CPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3232IDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
MAX3232IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.3	1.6	8.0	12.0	Q1
MAX3232IPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



www.ti.com 14-Nov-2025



*All dimensions are nominal

All difficultions are norminal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3232CDBR	SSOP	DB	16	2000	353.0	353.0	32.0
MAX3232CDR	SOIC	D	16	2500	340.5	336.1	32.0
MAX3232CDR1G4	SOIC	D	16	2500	353.0	353.0	32.0
MAX3232CPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232CPWR	TSSOP	PW	16	2000	367.0	367.0	35.0
MAX3232CPWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0
MAX3232IDBR	SSOP	DB	16	2000	353.0	353.0	32.0
MAX3232IDWR	SOIC	DW	16	2000	350.0	350.0	43.0
MAX3232IPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IPWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0
MAX3232IPWRG4	TSSOP	PW	16	2000	353.0	353.0	32.0

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025